Notice of Reference	ces Cited
---------------------	-----------

Application/Control No.	on/Control No. Applicant(s)/Patent Under		
10/692,666	Reexamination SHEN ET AL.		
Examiner	Art Unit		
Mia M. Thomas	2624	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0102022 A1	08-2002	Ma et al.	382/170
*	В	US-2003/0086606 A1	05-2003	Hunter et al.	382/167
*	С	US-2003/0103677 A1	06-2003	Tastl et al.	382/240
*	D	US-2004/0028271 A1	02-2004	Pollard et al.	382/162
*	Е	US-6,711,287 B1	03-2004	Iwasaki, Masajiro	382/165
*	F	US-6,798,921 B2	09-2004	Kinjo, Naoto	382/282
*	G	US-7,149,325 B2	12-2006	Pavlidis et al.	382/103
*	Н	US-7,215,812 B1	05-2007	Masaki, Kenji	382/167
*	T	US-7,336,817 B2	02-2008	Kasperkiewicz et al.	382/162
*	J	US-7,436,437 B2	10-2008	Fletcher et al.	348/208.6
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-FAIENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	٧			
	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.